Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/574,931	MIYAI ET AL	
Examiner	Art Unit	
Danny Worrell	3765	

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Class	Subclass	Date	Examiner
66	126R		
	64		
	60		
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	127	12/22/2006	LDW
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INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
PGPUB	S search	12/22/2006	LDW

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